

**Search Notes**

Application/Control No.

10/688,922

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

EZAWA ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	362 344	4/10/2007	NT
396	194 220	4/12/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	4/10/2007	NT
348/362-369 (text search - see search history printout)	4/10/2007	NT
Parent case 09/174095 references and IDS checked	4/10/2007	NT